Power MOSFETs

Panasonic

2SK3022

Silicon N-channel power MOSFET

Features

- Avalanche energy capability guaranteed
- High-speed switching
- Low ON resistance R_{on}
- No secondary breakdown
- Low-voltage drive
- High electrostatic energy capability

Applications

- Non-contact relay
- Solenoid drive
- Motor drive
- Control equipment
- Switching mode regulator

Absolute Maximum Ratings $T_C = 25^{\circ}C$

*				
Parameter	Symbol	Rating	Unit	
Drain-source surrender voltage	V _{DSS}	60	V	
Gate-source surrender voltage	V _{GSS}	±20	V	
Drain current	ID	±5	A	
Peak drain current	I _{DP}	±15	А	
Avalanche energy capability *	EAS	6.25	mJ	
Power dissipation	P _D	10	WO	
$T_a = 25^{\circ}C$		1		
Channel temperature	T _{ch}	150	S ℃	
Storage temperature	T _{stg}	-55 to +150	°C	

Note) *: L = 0.5 mH, $I_L = 5 A$, 1 pulse

Electrical Characteristics $T_C = 25^{\circ}C \pm 3^{\circ}C$

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Drain-source surrender voltage	V _{DSS}	$I_{\rm D} = 1 \text{ mA}, V_{\rm GS} = 0$	60			V
Drain-source cutoff current	I _{DSS}	$V_{\rm DS} = 50 \text{ V}, V_{\rm GS} = 0$	~?~		10	μΑ
Gate-source cutoff current	I _{GSS}	$V_{GS} = \pm 20 V, V_{DS} = 0$			±10	μΑ
Gate threshold voltage	V _{th}	$V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$	1.0		2.5	V
Forward transfer admittance	Y _{fs}	$V_{\rm DS} = 10 \text{ V}, I_{\rm D} = 3 \text{ A}$	2	4		S
Drain-source ON resistance	R _{DS(on)1}	$V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}$		90	130	mΩ
	R _{DS(on)2}	$V_{GS} = 4 V, I_D = 3 A$		130	200	
Diode forward voltage	V _{DSF}	$I_{DR} = 5 A, V_{GS} = 0$			-1.3	V
Short-circuit forward transfer capacitance (Common source)	C _{iss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$		220		pF
Short-circuit output capacitance (Common source)	C _{oss}	X		90		pF
Reverse transfer capacitance (Common source)	C _{rss}			50		pF
Turn-on delay time	t _{d(on)}	$V_{DD} = 30 \text{ V}, I_D = 3 \text{ A}, R_L = 10 \Omega$		15		ns
Rise time	t _r	$V_{GS} = 10 V$		30		ns
Fall time	t _f			170		ns
Turn-off delay time	t _{d(off)}			550		ns
Thermal resistance (ch-c)	R _{th(ch-c)}				12.5	°C/W
Thermal resistance (ch-a)	R _{th(ch-a)}				125	°C/W

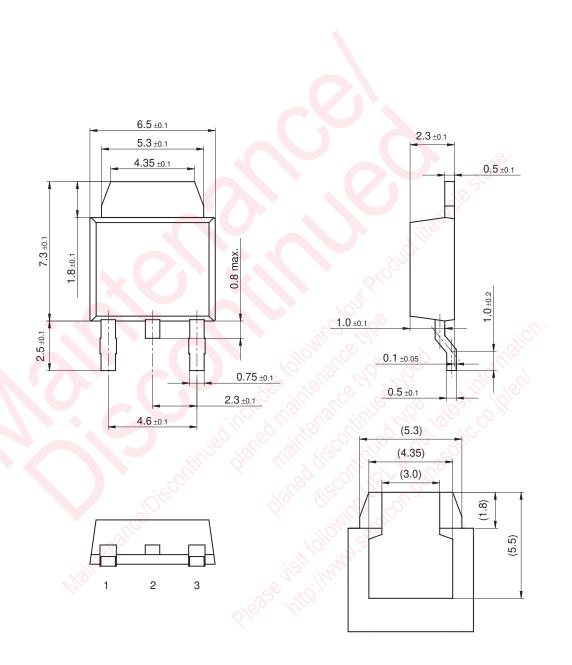
Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

- Code
- U-G2 • Pin Name
 - 1: Gate
 - 2: Drain
 - 3: Source
- Marking Symbol: K3022
- Internal Connection

2SK3022

U-G2

Unit: mm



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